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PATENT

8007-1087

IN THE U.S. PATENT AND TRADEMARK OFFICE

In re application of

Kiyotaka YASUDA et al. Conf. 6850

Application No. 10/522,791 Group 1745

Filed September 22, 2005 Examiner Unassigned

NEGATIVE ELECTRODE FOR NONAQUEOUS ELECTROLYTE
SECONDARY BATTERY, METHOD FOR MANUFACTURING SAME
AND NONAQUEOUS ELECTROLYTE SECONDARY BATTERY

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

May 2, 2007

Sir:

In compliance with Rules 1.97 and 1.98, and in fulfillment of the duty of disclosure under Rule 1.56, the accompanying document is made of record on the enclosed Form PTO-1449.

As the USPTO has waived the requirement under 37 CFR 1.98(a)(2)(i) for submitting a copy of each cited U.S. patent and patent publication for applications filed after June 30, 2003, a copy of the cited U.S. reference is not enclosed, as the present application is filed after June 30, 2003.

A concise explanation of the relevance of this item is that this reference was cited by the Taiwanese Patent Office in the corresponding Taiwanese application. A copy of

the Taiwanese Office Action is enclosed, together with an English translation.

Respectfully submitted,

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**INFORMATION DISCLOSURE CITATION
IN AN APPLICATION**

(Use several sheets if necessary)

Attorney Docket No.:
8007-1087

Application No.:
10/522,791

Applicant:
Kiyotaka YASUDA et al.

Filing Date:

Group Art Unit:
1745

U.S. PATENT DOCUMENTS

FOREIGN PATENT DOCUMENTS

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER: _____ **DATE CONSIDERED** _____

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.

* Abstract provided for the Examiner's convenience